Spin-related magnetoresistance of n-type ZnO A land Zn_{1 x}M n_xO A lthin lm s

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(D ated: M arch 23, 2024)

E ects of spin-orbit coupling and s-d exchange interaction are probed by m agnetoresistance m easurements carried out down to 50 mK on ZnO and Zn_{1 x} M n_xO with x = 3 and 7%. The lm s were obtained by laser ablation and doped with Alto electron concentration 10^{20} cm³. A quantitative description of the data for ZnO Al in terms of weak-localization theory makes it possible to determ ine the coupling constant $_{so} = (4.4 \ 0.4) \ 10^{11}$ eV cm of the kp ham iltonian for the wurzite structure, H $_{so} = _{so}c$ (s k). A complex and large m agnetoresistance of Zn_{1 x} M n_xO Al is interpreted in terms of the in uence of the s-d spin-splitting and m agnetic polaron form ation on the disorder-modil ed electron-electron interactions. It is suggested that the proposed model explains the origin of m agnetoresistance observed recently in many m agnetic oxide system s.

PACS num bers: 72.15 R n,72.25 R b,72.80 E y,75.50 P p

In the emerging eld of sem iconductor spintronics¹ spin-orbit and sp-d exchange interactions serve for spin m anipulation in nonm agnetic and m agnetic sem iconductors, respectively. At the same time, these interactions lim it spin coherence time in these systems. W ithin the standard D rude-Boltzm ann theory of charge transport, spin e ects contribute only weakly to the conductivity. However, electrons in doped wide band-gap sem iconductors are at the localization boundary, where charge transport is strongly a ected by quantum interference of both scattered waves and am plitudes of the electron-electron interaction. A coordingly, the conductance in these system s is sensitive to phase breaking mechanism s such as spin relaxation as well as to symmetry lowering perturbations such as the magnetic eld and Zeem an splitting of electronic states.²

In this paper we com pare magnetoresistance (MR) of non-magnetic n-ZnO and paramagnetic n-(Zn,Mn)O. In both cases MR contains positive and negative com ponents but its overall shape and m agnitude is very di erent, a behavior rem in iscent of that observed previously forn-CdSe and n-(Cd,Mn)Se.3 A quantitative description of the results dem on strates that MR of ZnO is dom in a ted by a destructive in uence of the magnetic eld on interference of scattered waves. This orbital e ect produces a sizable negative MR, which below 1 mT is perturbed by the so-called antilocalization caused by a spin-orbit coupling. We determ ine the corresponding coupling constant and compare it to results of available rst principles com putations. In the case of param agnetic n-(Zn,M n)O, we show that MR results primarily from the in uence of giant s-d spin splitting and spin scattering of bound m agnetic polarons on electron-electron interactions. These e ects produce large and strongly tem perature dependent positive and negative MR, respectively, the latter dom inating in the strongly localized regime, attained here due to strong self compensation. We argue that

our conclusions can be extended to other oxides, providing inform ation on m agnetic order and on the coupling of charge carriers to localized m agnetic m om ents.

 $Our Zn_{1 x} M n_{x} O$ thin Im s are grown by pulsed laser deposition technique⁴ on sapphire (0001) substrates, so that the c-axis of the wurzite structure is perpendicular to the lm plane. Technological M n contents x is 0, 0.03, and 0.07, for lm thicknesses d = 440, 310, and 310 nm, respectively. These Mn concentrations are consistent with SIMS as well as with the SQUID measurements.⁵ The SQUID data indicate that antiferrom agnetic interactions between the nearest neighbors are relevant only. This causes a reduction of the param agnetic spin concentration to $x_e = 0.020$ and 0.038 for the two (Zn,Mn)O samples in question if the M n m agnetic m om ent is 5:0 $_{\rm B}$. An uniform Aldoping with the concentration $x_{Al} = 0.5$ and 4% in the case of ZnO and (Zn,Mn)O, respectively, results in the high and temperature independent electron concentrations n = 1:8, 1.4 and 1:1 120 cm^{-3} for x = 0, 3, and 7%, respectively, according to Hall effect data. Transport m easurem ents are perform ed in four probe geom etry in a ${}^{3}\text{H}\,\text{e}/{}^{4}\text{H}\,\text{e}$ fridge down to 0.05 K, and in a ⁴He cryostat above T > 1.5 K by using a.c. lock-in technique. Two types of electric contacts have been em ployed. Indium contacts are easy to obtain by soldering m ethod, but they obscure high resolution m easurem ents when indium becomes superconducting. Accordingly, in the low tem perature range we use gold spring needles as contacts.

D espite rather sim ilar electron concentrations n, the resistivities of particular samples are rather di erent, as shown in Fig. 1(a). The determ ined values of the diagonal and H all resistivities lead to electron m obilities = 52, 14, and 2 cm²/Vs at 4.2 K for x = 0, 3, and 7%, respectively. In order to elucidate the origin of such a strong dependence (x) we rst evaluate the e ect of alloy and spin disorder scattering as-

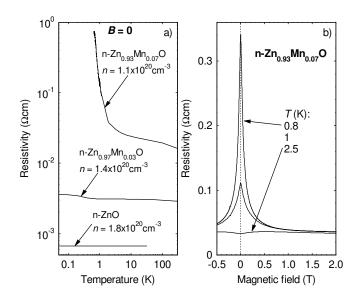


FIG.1: Resistivity as a function of tem perature (a) and m agnetic eld (b) for $Zn_{1 x} M n_x O$ and $Zn_{0:93} M n_{0:07} O$, respectively, revealing tem perature dependent localization.

sum ing the band o set between the conduction band of wurzite M nO and ZnO and the s-d exchange energy to be VN_o = 2 eV and N_o = 0.19 eV, respectively,⁶ where N_o = 4.24 ff cm³ is the cation concentration in ZnO. For the elective mass m = 0.3m_o the value of m obility limited by these scattering mechanisms is then 690 and 330 cm²/Vs for x = 3 and 7%, respectively, much too high to explain the experimental values.

W e note, however, that the large magnitude of VN $_{\circ}$ m ay account for a growing role of self-com pensation with x, and elucidate why electrical activity of Aldonors decreases so strongly with the Mn incorporation. Taking the static dielectric constant $_{\rm s}$ = 8 and assum ing that the relevant acceptor defects are singly ionized, that is that the total ionized in purity concentration is $N_{ii} = 2N_{o}x_{Al}$ n, we obtain from the Brooks-Herring formula $_{ii} = 82, 5.0, \text{ and } 4.1 \text{ cm}^2/\text{Vs for } x = 0, 3, \text{ and } 7\%$ respectively. These values correspond to $k_F l = 16, 0.86$, and 0.6, pointing out that the self-com pensation drives the system towards Anderson-Mott localization occurring when the product of the Ferm i wave vector \boldsymbol{k}_F and m ean free path lbecom es sm aller than one.² The proxim ity to the strongly localized regime is con med by a substantial tem perature dependence of resistivity observed for the 7% sample. The resistivity increase is particularly strong below 1 K [Fig. 1 (a)], and signalizes the so-called tem perature dependent localization, 3,6,7 associated with the form ation of bound m agnetic polarons. Colossalnegative MR at low tem peratures, shown in Fig. 1 (b), corroborates this conclusion.

Owing to the su ciently large experimental values of $k_F l$ in ZnO and $Zn_{0:97}M n_{0:03}O$, we expect M R in these samples to be described by quantum corrections to conductivity in the weakly localized regime.^{2,3} Figure 2(a) depicts M R of ZnO in the eld applied perpendicularly

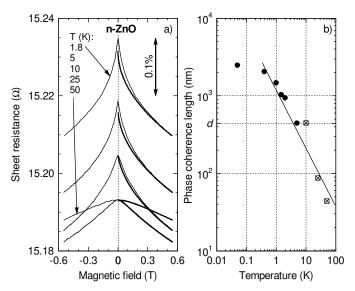


FIG.2: Resistance changes in the magnetic eld for n-ZnO (thin lines) compared to calculations (thick lines) within the weak localization theory for the 3D case. For T = 1.8 and 5 K the phase coherence length L, is set to in nity, while the tted values of L, at higher temperatures are plotted in (b) by squares. Dots denote L, determined by tting the weak-eld data presented in Fig.3. Straight line shows the dependence T $^{3-4}$ expected for L, (T) in the 3D case.

to the lm plane, that is along the c-axis. As seen, MR is negative and tem perature dependent, particularly in weak magnetic elds. Such character and magnitude of MR, of the order of 0.1% at B = 0.5 T, are sim ilar to that observed for an accumulation layer on ZnO.⁸ We assign this MR to a destructive e ect of the magnetic eld (vector potential) on constructive interference corresponding to two tim e-reversal paths along the sam e selfcrossing trajectories. Thick lines in Fig. 2 (a) has been calculated within this model by using K awabata's three dimensional (3D) form $u \ln 2^{2,9}$ treating the phase coherence length L_{γ} (T) as a tting parameter. It is apparent, how ever, that the model fails to describe the data quantitatively at low tem peratures and in low magnetic elds. W e assign this failure to a dim ensional cross-over, as according to the values of L, sum m arized in Fig. 2 (b), L, becom es greater than the sam ple thickness d below 10 K .

Figure 3 presents a comparison of experimental and calculated M R of ZnO in the magnetic eld below 6 m T. A characteristic positive component of M R, signalizing the presence of spin-orbit scattering, is detected below 1 m T at low temperatures. Similarly to the case of n-CdSe,³ we link this scattering to the presence of the term $_{so}c(s = k)$ in the kp ham iltonian of the wurzite structure, which in the employed geometry leads to the spin-orbit relaxation rates $_{sox}^{1} = \frac{1}{soy} = \frac{2}{so}k_{F}^{2} = 12=^{2};$ $_{soz}^{1} = 0,^{10}$ where is momentum relaxation time. Since L, (T) > d and the magnetic length $L_{B} = (\sim=eB)^{1=2} = d$ at 3.4 m T we describe the data by H ikam i et al. 2D theory,^{2,11} treating L, (T) and $_{so}$ as the tting param –

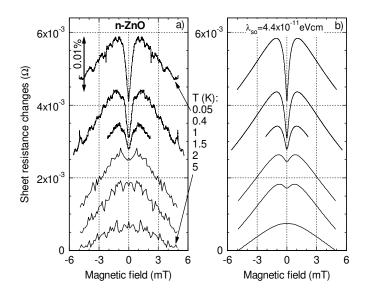


FIG. 3: Resistance changes in the magnetic eld for n-ZnO (a) compared to calculations (b) within the weak localization theory for the 2D case. Curves are vertically shifted for clarity and symmetrized.

eters. As shown in Fig. 3, we obtain a quite good description of our ndings with $_{so} = 4:4$ 10^{1} eV cm . Interestingly, the value of $_{so}$, determined within the present m odel with accuracy of about 10%, is by a factor two greater than that obtained by recent st principles com putations.¹² In contrast, the experim ental value for $C dSe_{\prime}^{3,13}$ so = (55 10) $1\theta^1$ eV cm is by a factor of two smaller than the theoretical result.¹² In any case, it is obvious that at a given electron density a dram atic reduction of $\frac{1}{s_0}$ occurs on going from heavier CdSe to lighter ZnO .F inally, we note that according to Fig. 2 (b), T $^{3=4}$ down to 0.5 K, as expected for the phase L, (T) breaking by electron-electron collisions in disordered 3D system s.² Since $L_T = (\sim D = k_B T)^{1=2} = d at 50 m K$, we assign a weaker tem perature dependence at low tem peratures to an onset of the dimensional cross-over, as in $T^{1=2}$.² However, at this stage, we the 2D case L, (T) cannot exclude perturbation e ects of stray elds or noise heating at the low est tem peratures, which m ay a ect the determ ined values of L, (T).

We now turn to MR found for the lm s of param agnetic (Zn,Mn)O, shown in Fig.4. A competition between positive and negative contributions to MR is clearly visible. D espite that the overall shape of MR is similar to that n-ZnO, its huge m agnitude as well as the eld and tem perature dependencies indicate that e ects brought about by the presence of the Mn spins dom inate. A c-tually, it has been shown previously^{3,6,14,15} that giant spin-splitting of band states in diluted m agnetic sem i-conductors a ects considerably quantum correction to the conductivity associated with the disorder m odi ed electron-electron interactions.² This results in positive MR,² if the Mn ions are not already spin-polarized in the absence of the magnetic eld. Furtherm ore, the spin-

splitting lead to a redistribution of the electrons between spin subbands, which dim inishes localization by increasing the carrier kinetic energy.¹⁶ In our case, how ever, the spin-splitting is more than ten times smaller than the Ferm i energy, which makes this mechanism of a minor im portance. We rather assign the negative component of MR to an enhancem ent of spin-disorder scattering associated with the form ation of bound magnetic polarons on approaching the strongly localized regim e,^{3,6} though quantitative theory of the e ect has not yet been elaborated. In line with this model, negative MR becomes stronger with decreasing tem perature and increasing M n

content.

We execute MR calculations for (Zn,Mn)O with no tting parameter taking into account both single-electron and many-body quantum e ects in the weakly localized regime, $k_{\rm F} = 1.2$ Because of sm aller m agnitude of di usion constant in (Zn,Mn)O comparing to ZnO, we employ the 3D form ulae.² The spin-splitting of the conduction band contains the Zeem an term $q_B H$, where q = 2.0 in ZnO , and the s-d contribution $x_{\rm e}$ $\,$ N $_{\rm o}$ SB $_{\rm S}$ (T ;H), where the numerical values of x_e and N $_{\circ}$ have been given above and, in the tem perature range of interest here, B_S is the param agnetic Brillouin function for S = 5=2. The parameter describing the magnitude of electronelectron interaction in the triplet channel is taken as $F = 2g_3 = 1$. Furtherm ore, for , (T) we adopt the values obtained for ZnO. As shown in Figs. 4 (a,b), the calculation for the 3% sample reproduces well the com petition between negative and positive contributions to MR at high tem peratures. At lower tem peratures, however, only positive component is properly described in the range of the weak elds. In high elds and at low tem peratures, in turn, we deal with an additional negative contribution, which is too large to be explained by the em ployed weak-localization theory. We regard this e ect as a precursor of the polaron form ation. This situation is even m ore m arked for x = 7% sam ple, for which the com parison between m easured and calculated MR is depicted in Figs. 4 (c,d). We note that $k_F l$ 2:4 and k 1 0:2 for the x = 3% and x = 7% samples, respectively, which means that the 7% sample is in the strongly localized regime, for which polaron e ects should be particularly im portant.

In sum mary, we have determ ined the magnitude of spin-orbit relaxation time of electrons in ZnO by describing quantitatively high-resolution low-temperature MR measurements in terms of quantum corrections to the conductivity of disordered systems. Within our interpretation, this spin scattering rate is proportional to the square of the coupling constant between the spin and momentum, in contrast to the corresponding band splitting that is linear in $_{so}$. A ccordingly, wide-band gap sem iconductors for which $_{so}$ is small, appear to be particularly suitable for spin manipulation by spin-orbit e ects. A small magnitude of $_{so}$ makes also the corresponding MR to become dominated, in rather weak magnetic elds, by MR associated with the in uence of

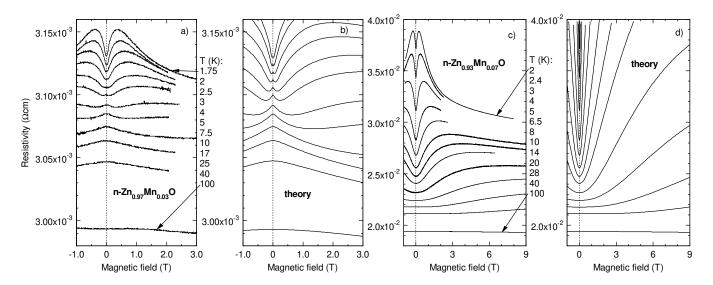


FIG. 4: Measured (a,c) and calculated with no adjustable parameter (b,d) resistivity changes in the magnetic eld for $n-2n_{0:97}Mn_{0:03}O$ (a,b) and $n-2n_{0:93}Mn_{0:07}O$ (c,d). Weak localization theory takes into account elects of the magnetic eld on interference of scattered waves and of the spin-splitting on disorder modil ed electron-electron interactions but neglects elects associated with the formation of magnetic polarons, which are thought to result in negative magnetoresistance at low temperatures.

the vector potential on interference of self-crossing trajectories. Interestingly, this orbital e ect m akes negative M R to be a characteristic feature of non-m agnetic sem iconductors, while the presence of a giant spin-splitting, speci c to diluted m agnetic sem iconductors in a param agnetic phase, gives rise to large positive M R. This is in contrast to both diluted m agnetic m etals and m agnetic sem iconductors in the strongly localized regim e, in which negative, not positive, M R points to the presence of a coupling between localized spins and charge carriers. In diluted m agnetic sem iconductors at the localization boundary, there is a coexistence of positive and negative M R caused by the spin-splitting and the form ation of bound m agnetic polarons, respectively. The latter takes over at low tem peratures and to our know ledge has not yet been described theoretically. Im portantly, the m odel of M R invoked here appears to explain qualitatively the ndings reported previously for (ZnMn)O,⁴ (Zn,Co)O,¹⁷ (Zn,Fe)O,¹⁸ $(SnMn)O_2$,¹⁹ (T iC o)O_2,²⁰ to quote only a few examples. In particular, the presence of sizable positive M R, suggests that the band splitting vanishes in the absence of an external magnetic eld.

W e thank Hideo Ohno and Maciej Sawicki for valuable discussions. This work was partly supported by PBZ/KBN/044/P03/2001 G rant and ERATO Sem iconductor Spintronics Project.

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- ¹ SA.W olfet al, Science 294, 1488 (2001); T.D ietl, Acta Phys.Polon.A 100 (suppl.), 139 (2001); H.Ohno et al, JSAP International 5, 4 (2002); I.Zutic et al, Rev.M od. Phys. 76, 323 (2004).
- ² B.L. Altshuler, A.G. Aronov in: Electron-Electron Interactions in D isordered Systems, edited by A.L. E fros and M. Pollak (North Holland, Am sterdam, 1985) p. 1; H. Fukuyama, ibid, p. 155; P.A. Lee and T.V. Ram akrishnan, Rev. M od. Phys. 57, 287 (1985).
- ³ M.Sawickiet al, Phys. Rev. Lett. 56, 508 (1986).
- ⁴ T.Fukum ura et al, Appl. Phys. Lett. 75, 3366 (1999).
- ⁵ M.Sawickietal, unpublished.
- ⁶ T.D ietl in: Handbook on Sem iconductors, edited by T.S. Moss, vol. 3B (North Holand, Am sterdam, 1994) p.1251.
- ⁷ D.Ferrand et al, Phys.Rev.B 63, 085201 (2001).

- ⁸ A.Goldenblum et al, Phys. Rev. B 60, 5832 (1999).
- ⁹ A.Kawabata, J.Phys.Soc.Jpn.49, 628 (1980).
- ¹⁰ B L. Altshuler et al., in Quantum Theory of Solids, edited by IM. Lifshits (M ir Publishers, M oscow, 1982), p.130, and references therein.
- ¹¹ S.Hikam iet al, Prog. Theor. Phys. 63, 707 (1980).
- ¹² L.C. Lew Yan Voon et al, Phys. Rev. B 53, 10703 (1996).
- ¹³ M .D obrow olska et al, Phys. Rev. B 29, 6652 (1984)
- ¹⁴ IP.Sm orchkova et al, Phys.Rev.Lett. 78, 3571 (1997).
- $^{\rm 15}$ T.Andrearczyk et al., Phys.E 12, 361 (2002).
- ¹⁶ H. Fukuyam a and K. Yoshida, J. Phys. Soc. Japan 46, 1522 (1979).
- ¹⁷ Jae Hyun K in et al, Phys. B 327, 304 (2003).
- ¹⁸ S-J. Han et al, Appl. Phys. Lett. 81, 4212 (2002).
- ¹⁹ H.K im ura et al, Appl. Phys. Lett. 80, 94 (2002).
- ²⁰ S.R. Shinde et al, Phys. Rev. B 67, 115211 (2003).